EMC TEST REPORT
For

POWER BANK

Model No.: UP-808

Prepared for	:	
Address	:	

Prepared by	:	Shenzhen LCS Compliance Testing Laboratory Ltd.
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Date of receipt of test sample	:	October 12, 2017
Number of tested samples	:	1
Serial number	:	Prototype
Date of Test	:	October 12, 2017 ~ October 23, 2017
Date of Report	:	October 23, 2017

EMC TEST REPORT
EN 55032: 2015
Electromagnetic compatibility of multimedia equipment - Emission Requirements
EN 55024: 2010
Information technology equipment-Immunity characteristics-Limits and methods of measurement of measurement

Report Reference No. .....: LCS171012043AE

Date of Issue.....: October 23, 2017

Testing Laboratory Name.....: Shenzhen LCS Compliance Testing Laboratory Ltd.

Address.....: 1/F., Xingyuan Industrial Park, Tongda Road, Bao'an Avenue, Bao'an District, Shenzhen, Guangdong, China

Testing Location/ Procedure .....: Full application of Harmonised standards ■
Partial application of Harmonised standards ☐
Other standard testing method ☐

Applicant's Name.....:

Address.....:

Test Specification:

Standard .....: EN 55032: 2015
EN 55024: 2010

Test Report Form No. .....: LCSEMC-1.0

TRF Originator.....: Shenzhen LCS Compliance Testing Laboratory Ltd.

Master TRF .....: Dated 2011-03

Test Item Description.....: POWER BANK

Trade Mark.....: N/A

Model/ Type Reference.....: UP-808

Ratings .....: Input:5V⎓2A
Output:USB1:5V⎓2A; USB2:5V⎓2A

Result .....: Positive

Compiled by:	**Supervised by:**	**Approved by:**
Hana Zeng	Davey Xu	Gavin Liang
Hana Zeng/File administrators	Davey Xu/ Technique principal	Gavin Liang/ Manager

EMC -- TEST REPORT

Test Report No. : LCS171012043AE	October 23, 2017 Date of issue

Type / Model.....	: UP-808
EUT.....	: POWER BANK
Applicant.....	**:**
Address.....	:
.	
Telephone.....	: /
Fax.....	: /
Manufacturer.....	**:**
Address.....	:
Telephone.....	: /
Fax.....	: /
Factory.....	**:**
Address.....	:
Telephone.....	: /
Fax.....	: /

Test Result according to the standards on page 6: **Positive**

The test report merely corresponds to the test sample.
It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

Revision History

Revision	Issue Date	Revisions	Revised By
000	October 23, 2017	Initial Issue	Gavin Liang

TABLE OF CONTENT

Test Report Description Page

1. SUMMARY OF STANDARDS AND RESULTS

1.1.Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below.

EMISSION (EN 55032: 2015)			
Description of Test Item	**Standard**	**Limits**	**Results**
Conducted disturbance at mains terminals	EN 55032: 2015	Class B	N/A
Conducted disturbance at telecommunication port	EN 55032: 2015	Class B	N/A
Radiated disturbance	EN 55032: 2015	Class B	PASS
Harmonic current emissions	EN 61000-3-2: 2014	Class A	N/A
Voltage fluctuations & flicker	EN 61000-3-3: 2013	--------	N/A

IMMUNITY(EN 55024: 2010)			
Description of Test Item	**Basic Standard**	**Performance Criteria**	**Results**
Electrostatic discharge (ESD)	EN 61000-4-2: 2009	B	PASS
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A2: 2010	A	PASS
Electrical fast transient (EFT)	EN 61000-4-4: 2012	B	N/A
Surge (Input a.c. power ports)	EN 61000-4-5: 2014	B	N/A
Surge (Telecommunication ports)		B	N/A
Radio-frequency, Continuous conducted disturbance	EN 61000-4-6: 2014	A	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	A	PASS
Voltage dips, >95% reduction	EN 61000-4-11: 2004	B	N/A
Voltage dips, 30% reduction		B	N/A
Voltage interruptions		C	N/A
N/A is an abbreviation for Not Applicable.			

Test mode:		
Mode 1	Charge	Pre-scan
Mode 2	Discharge	Record
Mode 3	Charging And Discharging(Full Load)	Pre-scan

1.2.Description of Performance Criteria

General Performance Criteria

Examples of functions defined by the manufacturer to be evaluated during testing include, but are not limited to, the following:

— essential operational modes and states;
— tests of all peripheral access (hard disks, floppy disks, printers, keyboard, mouse, etc.);
— quality of software execution;
— quality of data display and transmission;
— quality of speech transmission.

1.2.1.Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacture when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.2.Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacture, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operation state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.3.Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacture’s instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be loss.

2. GENERAL INFORMATION

2.1.Description of Device (EUT)

EUT	:	POWER BANK
Trade Mark	:	N/A
Model Number	:	UP-808
Power Supply	:	Input:5V⎓2A Output:USB1:5V⎓2A; USB2:5V⎓2A
EUT Clock Frequency	:	≤ 108MHz

2.2.Description of Test Facility

EMC Lab. : CNAS Registration Number. is L4595.

FCC Registration Number. is CN5024.

Industry Canada Registration Number. is 9642A-1.

ESMD Registration Number. is ARCB0108.

UL Registration Number. is 100571-492.

TUV SUD Registration Number. is SCN1081.

TUV RH Registration Number. is UA 50296516-001

NVLAP Registration Code. is 600167-0.

2.3.Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To CISPR 16 – 4 “Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements” and is documented in the LCS quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

2.4.Measurement Uncertainty

Test Item	Frequency Range	Expanded uncertainty (Ulab)	Expanded uncertainty (Ucispr)
Radiated Emission	Level accuracy (9kHz to 30MHz)	± 3.68 dB	N/A
Radiated Emission	Level accuracy (30MHz to 1000MHz)	± 3.48 dB	± 5.2 dB
Radiated Emission	Level accuracy (above 1000MHz)	± 3.90 dB	N/A

(1) Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus.

(2) The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor of k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

3. MEASURING DEVICES AND TEST EQUIPMENT

3.1.Radiated Disturbance (Electric Field)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2017-06-17
2	EMI Test Receiver	ROHDE & SCHWARZ	ESR 7	101181	2017-06-17
3	Log per Antenna	SCHWARZBECK	VULB9163	9163-470	2017-04-17
4	EMI Test Software	AUDIX	E3	N/A	2017-06-17
5	Positioning Controller	MF	MF-7082	/	2017-06-17

3.2.Electrostatic Discharge

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ESD Simulator	SCHLODER	SESD 230	604035	2017-06-17

3.3.RF Field Strength Susceptibility

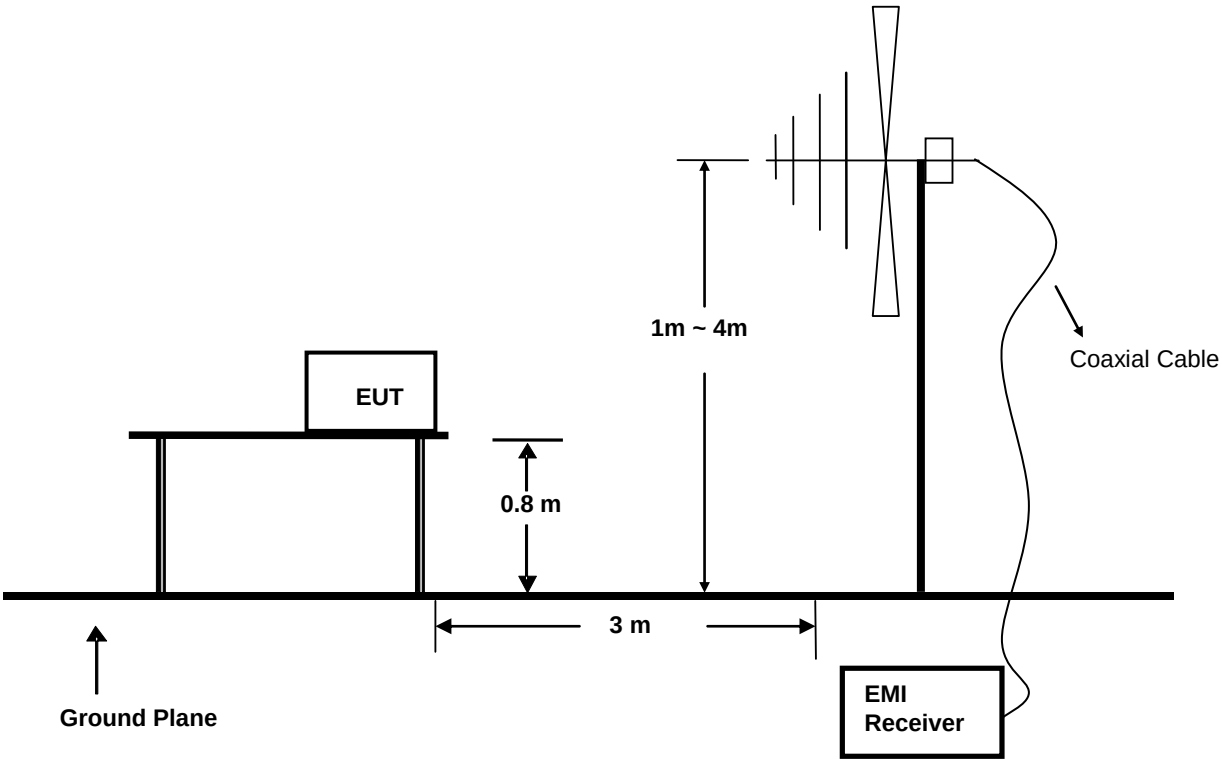
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	RF POWER AMPLIFIER	OPHIR	5225R	1052	2017-03-22
2	RF POWER AMPLIFIER	OPHIR	5273F	1019	2017-03-24
3	Stacked Broadband Log Periodic Antenna	SCHWARZBECK	STLP 9128	9128ES-145	2017-04-28
4	Stacked Mikrowellen Log.-Per Antenna	SCHWARZBECK	STLP 9149	9149-482	2017-04-28
5	Signal Generator	Agilent	E4438C	MY42081396	2016-11-18
6	Electric field probe	Narda S.TS./PMM	EP601	611WX70332	2017-02-05
7	Power Meter	Agilent	E4419B	MY45104493	2017-06-17
8	Power Sensor	Agilent	E9301H	MY41495234	2017-06-17
9	Power Sensor	Agilent	E4412A	MY41500229	2017-06-17

3.4.Power Frequency Magnetic Field Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power frequency mag-field generator System	EVERFINE	EMS61000-8K	906003	2017-06-17

4. RADIATED EMISSION MEASUREMENT

4.1.Block Diagram of Test Setup



4.2.Measuring Standard

EN 55032: 2015

4.3.Radiated Emission Limits

EN 55032 Limits:

All emanations from a class B device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

FREQUENCY (MHz)	DISTANCE (Meters)	FIELD STRENGTHS LIMIT (dBμV/m)
30 ~ 230	3	40
230 ~ 1000	3	47

Note: (1) The smaller limit shall apply at the combination point between two frequency bands.
(2) Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the EUT.

4.4.EUT Configuration on Test

The EN 55032regulations test method must be used to find the maximum emission during radiated emission measurement.

4.5.Operating Condition of EUT

4.5.1 Turn on the power.

4.5.2 After that, let the EUT work in test mode (Mode 2) and measure it.

4.6.Test Procedure

The EUT is placed on a turntable, which is 0.8 meter high above the ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna, which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. By-log antenna is used as a receiving antenna. Both horizontal and vertical polarization of the antenna is set on test.

The bandwidth of the Receiver is set at 120kHz.

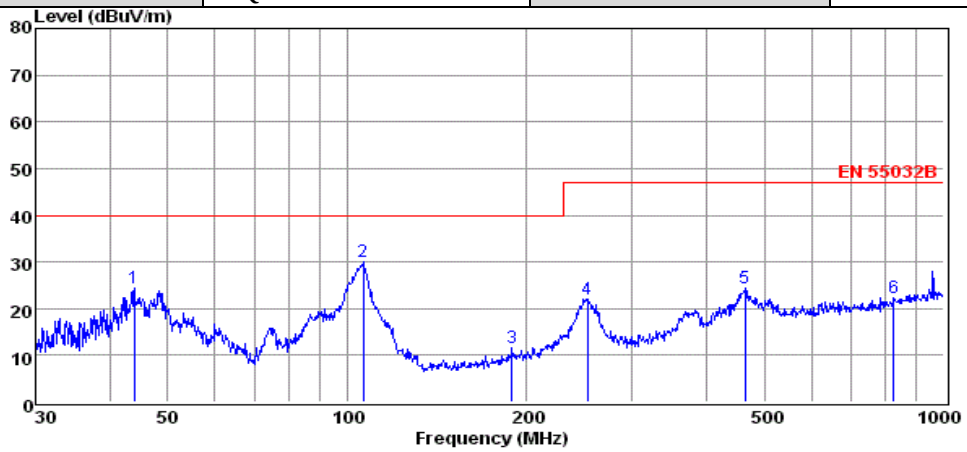
The frequency range from 30MHz to 1000MHz is investigated.

4.7.Test Results

PASS.

The test result please refer to the next page.

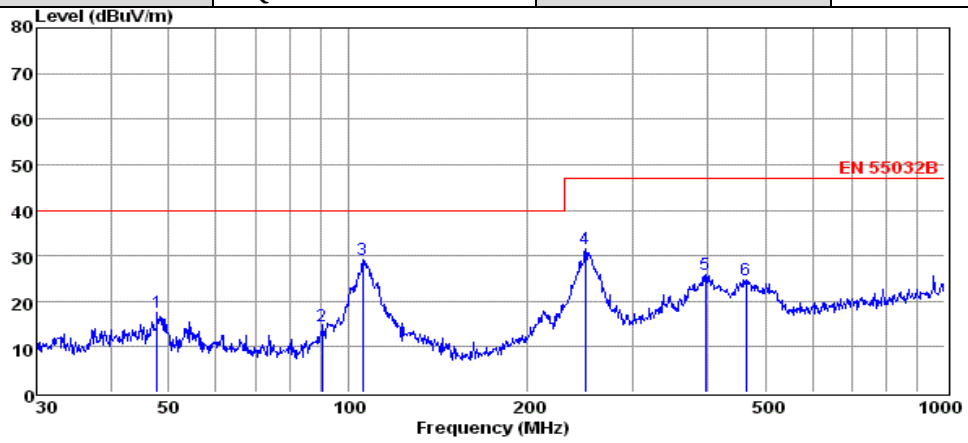
Model No.	UP-808	**Test Mode**	Mode 2
Environmental Conditions	24.4℃, 55.6% RH	**Detector Function**	Quasi-peak
Pol	Vertical	**Distance**	3m
Test Engineer	LQP Luo		



	Freq MHz	Reading dBuV	CabLos dB	Antfac dB/m	Measured dBuV/m	Limit dBuV/m	Over dB	Remark
1	43.97	10.29	0.41	13.56	24.26	40.00	-15.74	QP
2	106.39	16.86	0.68	12.58	30.12	40.00	-9.88	QP
3	189.07	0.23	0.86	10.48	11.57	40.00	-28.43	QP
4	252.95	9.09	0.90	12.06	22.05	47.00	-24.95	QP
5	463.97	7.27	1.36	15.69	24.32	47.00	-22.68	QP
6	824.60	0.11	1.80	20.31	22.22	47.00	-24.78	QP

Note: 1. All readings are Quasi-peak values.
2. Measured= Reading + Antenna Factor + Cable Loss
3. The emission that ate 20db blow the offficial limit are not reported

Model No.	UP-808	**Test Mode**	Mode 2
Environmental Conditions	24.4℃, 55.6% RH	**Detector Function**	Quasi-peak
Pol	Horizontal	**Distance**	3m
Test Engineer	LQP Luo		



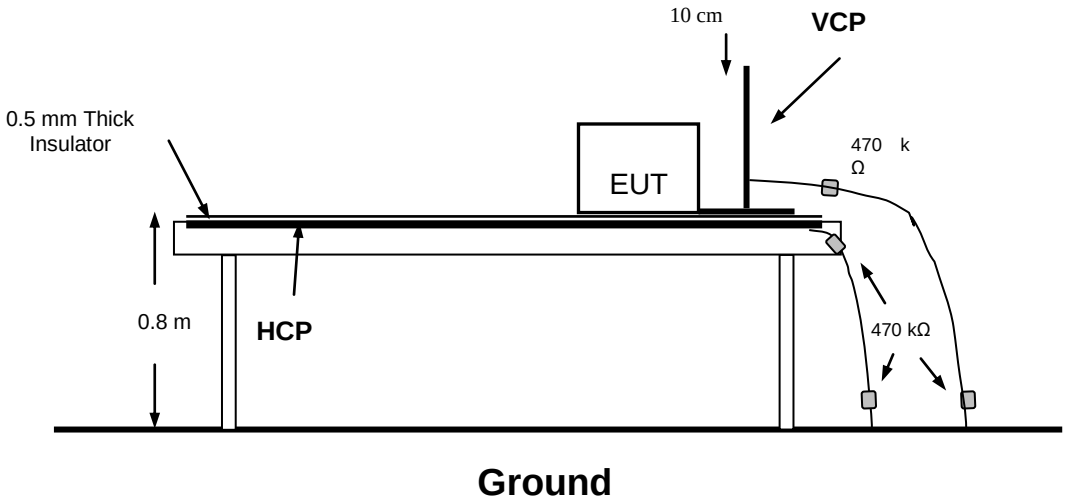
	Freq MHz	Reading dBuV	CabLos dB	Antfac dB/m	Measured dBuV/m	Limit dBuV/m	Over dB	Remark
1	47.83	3.70	0.35	13.38	17.43	40.00	-22.57	QP
2	90.22	1.91	0.68	11.94	14.53	40.00	-25.47	QP
3	105.64	15.98	0.61	12.65	29.24	40.00	-10.76	QP
4	249.43	18.45	1.02	12.07	31.54	47.00	-15.46	QP
5	397.63	9.57	1.22	15.00	25.79	47.00	-21.21	QP
6	463.97	7.75	1.36	15.69	24.80	47.00	-22.20	QP

Note: 1. All readings are Quasi-peak values.
2. Measured= Reading + Antenna Factor + Cable Loss
3. The emission that ate 20db blow the offficial limit are not reported

Note: Pre-Scan all mode, Thus record worse case mode result in this report.

5. ELECTROSTATIC DISCHARGE IMMUNITY TEST

5.1.Block Diagram of Test Setup



5.2.Test Standard

EN 55024: 2010, (EN 61000-4-2: 2009, Severity Level: 3 / Air Discharge: ±8KV, Level: 2 / Contact Discharge: ±4KV)

5.3.Severity Levels and Performance Criterion

5.3.1.Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
X	Special	Special

5.3.2.Performance Criterion: **B**

5.4.EUT Configuration on Test

The configuration of EUT is listed in Section 2.1.

5.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 4.5, Except the test set up replaced by Section 5.1.

5.6.Test Procedure

5.6.1.Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT.
After each discharge, the discharge electrode shall be removed from the EUT.
The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed

5.6.2.Contact Discharge

All the procedure shall be same as Section 5.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.6.3.Indirect Discharge For Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.6.4.Indirect Discharge For Vertical Coupling Plane

At least 10 single discharge (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.7.Test Results

PASS.

Please refer to the following pages

Electrostatic Discharge Test Results

Standard	☐ IEC 61000-4-2 ☑ EN 61000-4-2		
Applicant			
EUT	POWER BANK	**Temperature**	24.4℃
M/N	UP-808	**Humidity**	55.1%
Criterion	B	**Pressure**	1021mbar
Test Mode	Mode 2	**Test Engineer**	LQP Luo

Air Discharge

Test Points	Test Levels			Results		
	± 2kV	± 4kV	± 8kV	Passed	Fail	Performance Criterion
Front	☒	☒	☒	☒	☐	☐A ☒B
Back	☒	☒	☒	☒	☐	☐A ☒B
Left	☒	☒	☒	☒	☐	☐A ☒B
Right	☒	☒	☒	☒	☐	☐A ☒B
Top	☒	☒	☒	☒	☐	☐A ☒B
Bottom	☒	☒	☒	☒	☐	☐A ☒B

Contact Discharge

Test Points	Test Levels		Results		
	± 2 kV	±4 kV	Passed	Fail	Performance Criterion
Front	☒	☒	☒	☐	☐A ☒B
Back	☒	☒	☒	☐	☐A ☒B
Left	☒	☒	☒	☐	☐A ☒B
Right	☒	☒	☒	☐	☐A ☒B
Top	☒	☒	☒	☐	☐A ☒B
Bottom	☒	☒	☒	☐	☐A ☒B

Discharge To Horizontal Coupling Plane

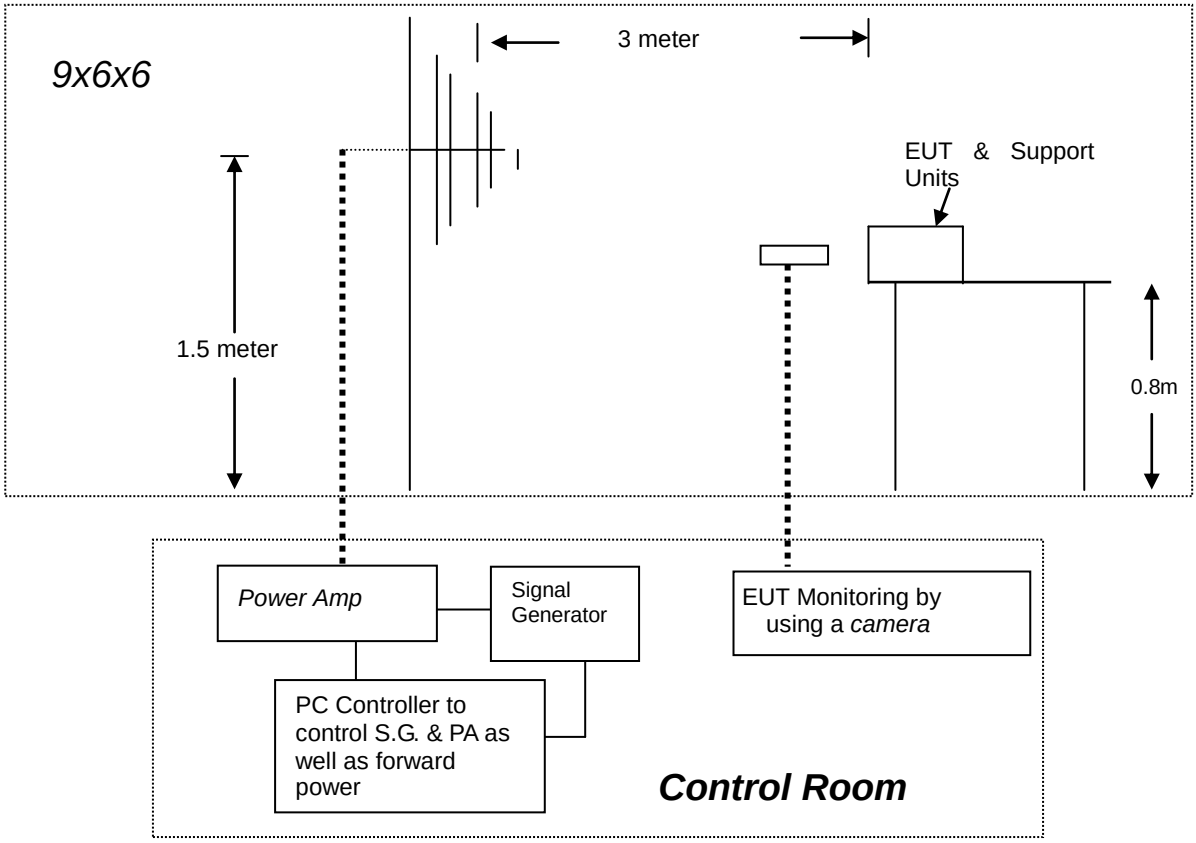
Side of EUT	Test Levels		Results		
	± 2 kV	± 4 kV	Passed	Fail	Performance Criterion
Front	☒	☒	☒	☐	☐A ☒B
Back	☒	☒	☒	☐	☐A ☒B
Left	☒	☒	☒	☐	☐A ☒B
Right	☒	☒	☒	☐	☐A ☒B

Discharge To Vertical Coupling Plane

Side of EUT	Test Levels		Results		
	± 2 kV	± 4 kV	Passed	Fail	Performance Criterion
Front	☒	☒	☒	☐	☐A ☒B
Back	☒	☒	☒	☐	☐A ☒B
Left	☒	☒	☒	☐	☐A ☒B
Right	☒	☒	☒	☐	☐A ☒B

6. RF FIELD STRENGTH SUSCEPTIBILITY TEST

6.1.Block Diagram of Test



6.2.Test Standard

EN 55024: 2010

(EN 61000-4-3: 2006+A2: 2010, Severity Level: 2, 3V / m)

6.3.Severity Levels and Performance Criterion

6.3.1.Severity Levels

Level	Field Strength (V/m)
1.	1
2.	3
3.	10
X.	Special

6.3.2.Performance Criterion: **A**

6.4.EUT Configuration on Test

The configuration of the EUT is same as Section 2.1.

6.5.Operating Condition of EUT

Same as radiated emission measurement, which is listed in Section 4.5, except the test setup replaced as Section 6.1.

6.6.Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.
In order to judge the EUT performance, a CCD Recording is used to monitor its screen.
All the scanning conditions are as following:

Condition of Test	Remark
1. Fielded Strength	3V/m (Severity Level 2)
2. Radiated Signal	Unmodulated
3. Scanning Frequency	80-1000MHz
4. Sweep time of radiated	0.0015 Decade/s
5. Dwell Time	3 Sec.

6.7.Test Results

PASS.

Please refer to the following page.

RF Field Strength Susceptibility Test Results

Standard	☐ IEC 61000-4-3 ☑ EN 61000-4-3		
Applicant			
EUT	POWER BANK	**Temperature**	24.4℃
M/N	UP-808	**Humidity**	55.6%
Field Strength	3 V/m	**Criterion**	A
Test Mode	Mode 2	**Test Engineer**	LQP Luo
Frequency Range	80 MHz to 6GHz		
Modulation	☐None ☐ Pulse ☑AM 1KHz 80%		
Steps	1%		

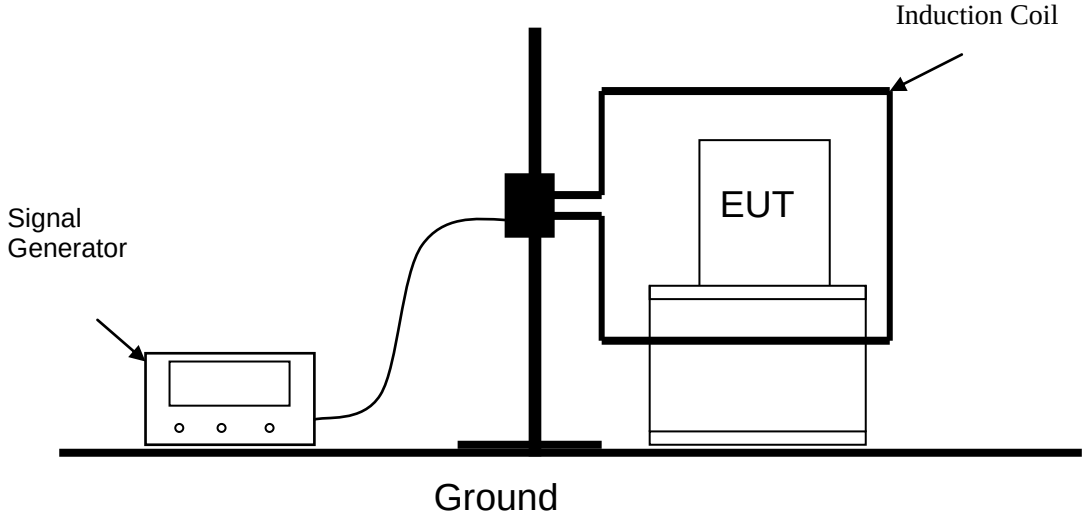
	Horizontal	Vertical
Front	PASS	PASS
Right	PASS	PASS
Rear	PASS	PASS
Left	PASS	PASS

Test Equipment:
1. Signal Generator: 2031 (MARCONI)
2. Power Amplifier: 500A100 & 100W/1000M1 (A&R)
3. Power Antenna: 3108 (EMCO) & AT1080 (A&R)
4. Field Monitor: FM2000 (A&R)

Note:

7. MAGNETIC FIELD SUSCEPTIBILITY TEST

7.1.Block Diagram of Test Setup



7.2.Test Standard

EN 55024: 2010

(EN 61000-4-8: 2010, Severity Level: Level 1, 1A / m)

7.3.Severity Levels and Performance Criterion

7.3.1.Severity Levels

Level	Field Strength (A/m)
1	1
2	3
3	10
4	30
5	100
X	Special

7.3.2.Performance Criterion: **A**

7.4.EUT Configuration on Test

The configuration of the EUT is same as Section 2.1.

7.5.Test Procedure

The EUT is placed in the middle of a induction coil (1*1m), under which is a 1*1*0.1m (high) table, this small table is also placed on a larger table, 0.8 m above the ground. Both horizontal and vertical polarization of the induction coil is set on test, so that each side of the EUT is affected by the magnetic field. Also can reach the same aim by change the position of the EUT.

7.6.Test Results

PASS.

Please refer to the following page.

Magnetic Field Immunity Test Result

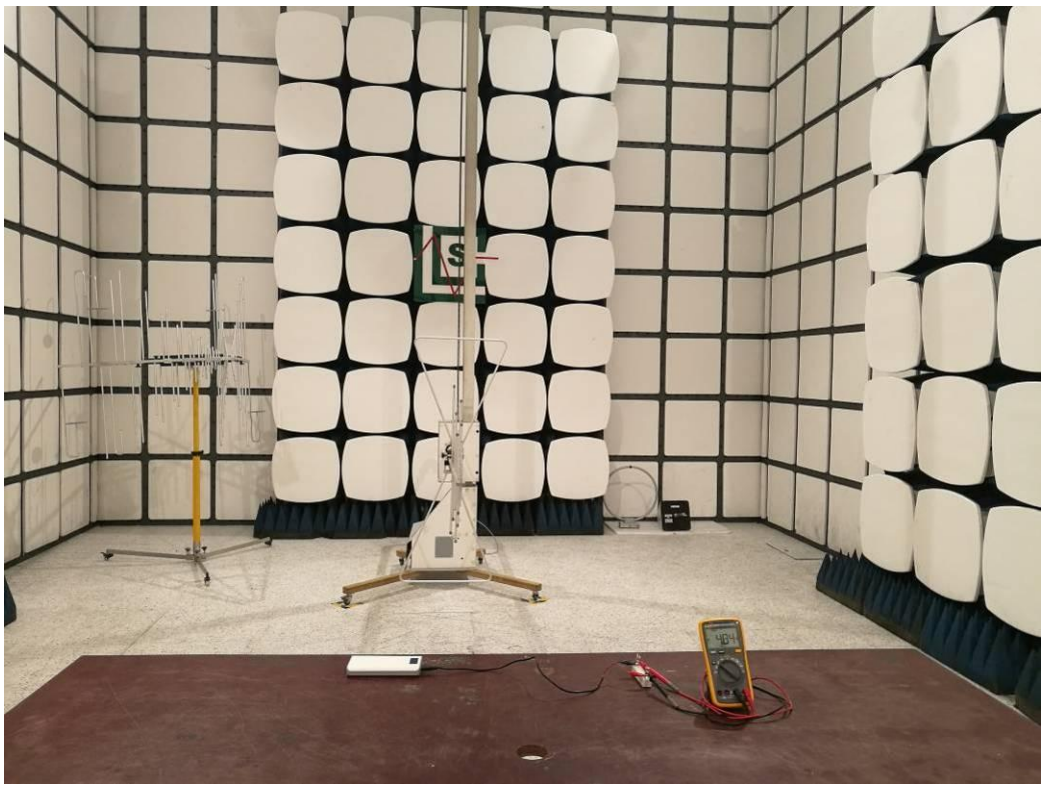
Standard	☐ IEC 61000-4-8 ☑ EN 61000-4-8		
Applicant			
EUT	POWER BANK	**Temperature**	24.1℃
M/N	UP-808	**Humidity**	55.6％
Test Mode	Mode 2	**Criterion**	A
Test Engineer	LQP Luo		

Test Level (A/M)	Testing Duration	Coil Orientation	Criterion	Result
1	5 mins	X	A	PASS
1	5 mins	Y	A	PASS
1	5 mins	Z	A	PASS

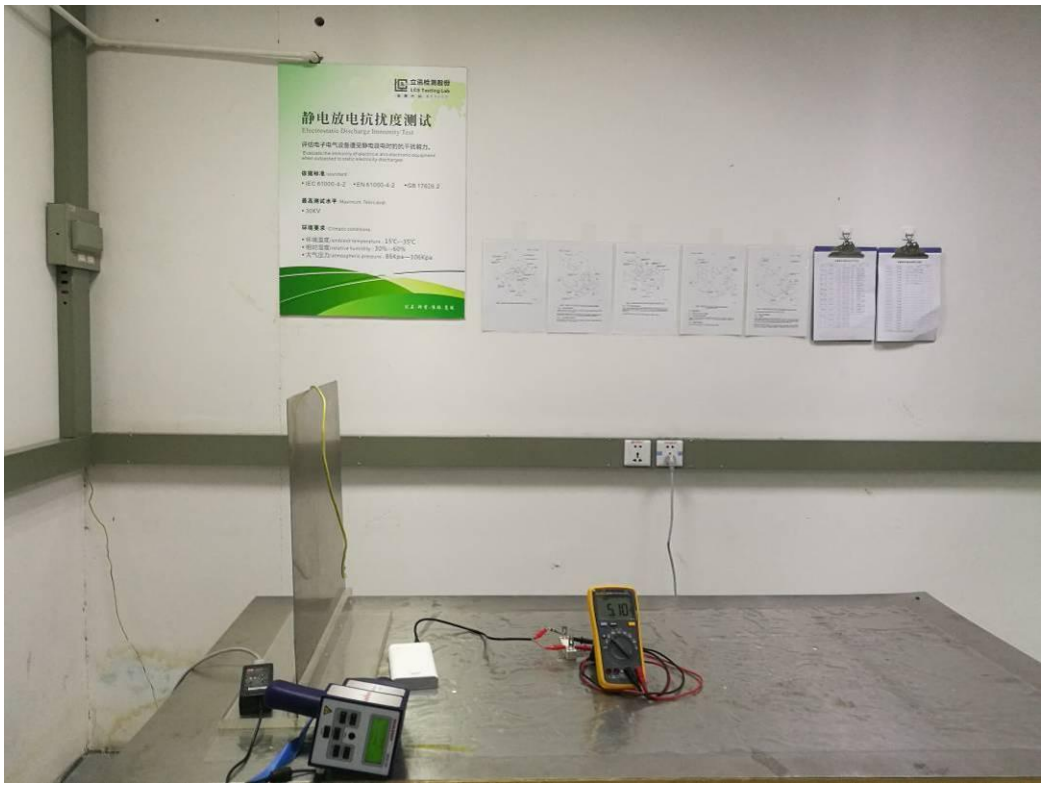
Note:

8. PHOTOGRAPH

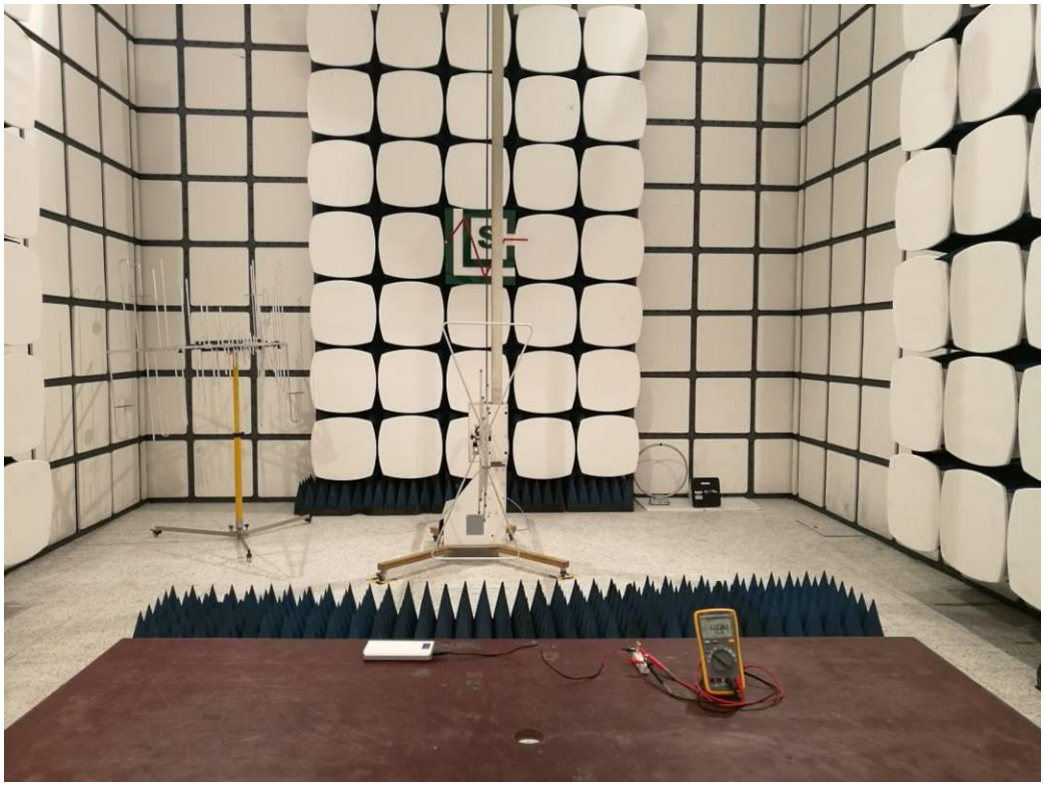
8.1.Photo of Radiated Measurement



8.2. Photo of Electrostatic Discharge Test



8.3.Photo of Radio-frequency, Continuous radiated disturbance



8.4.Photo of Magnetic Field Immunity Test

9. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Fig 1

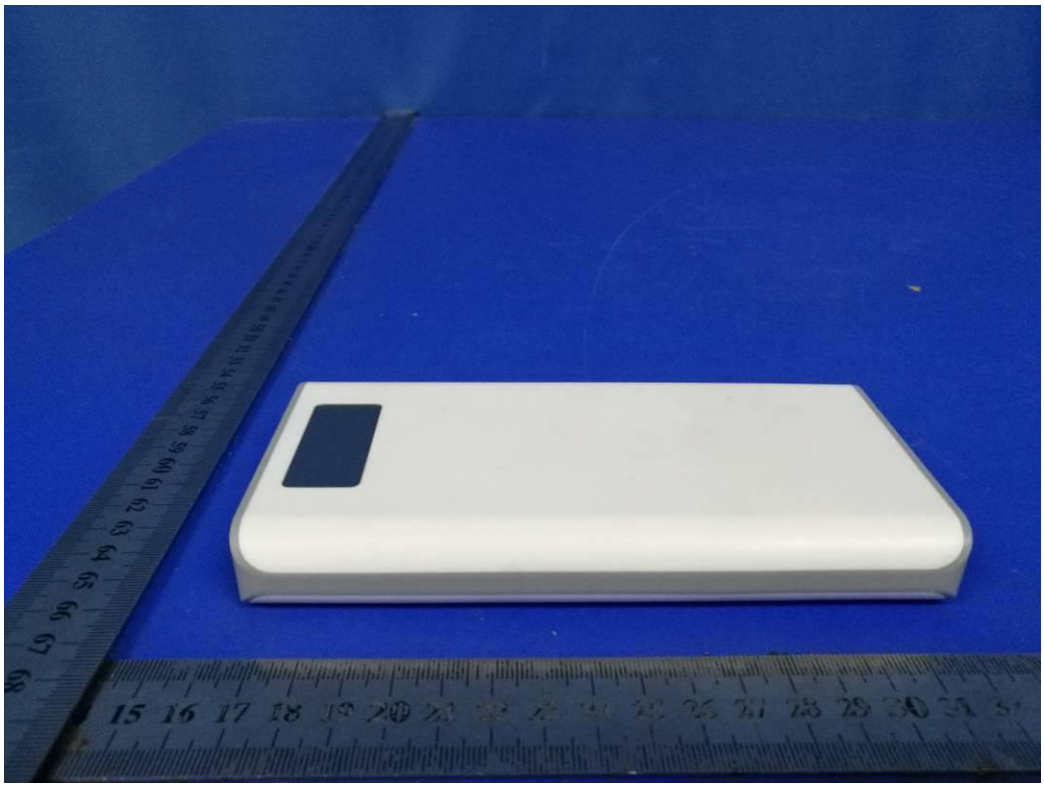


Fig 2

Fig 3

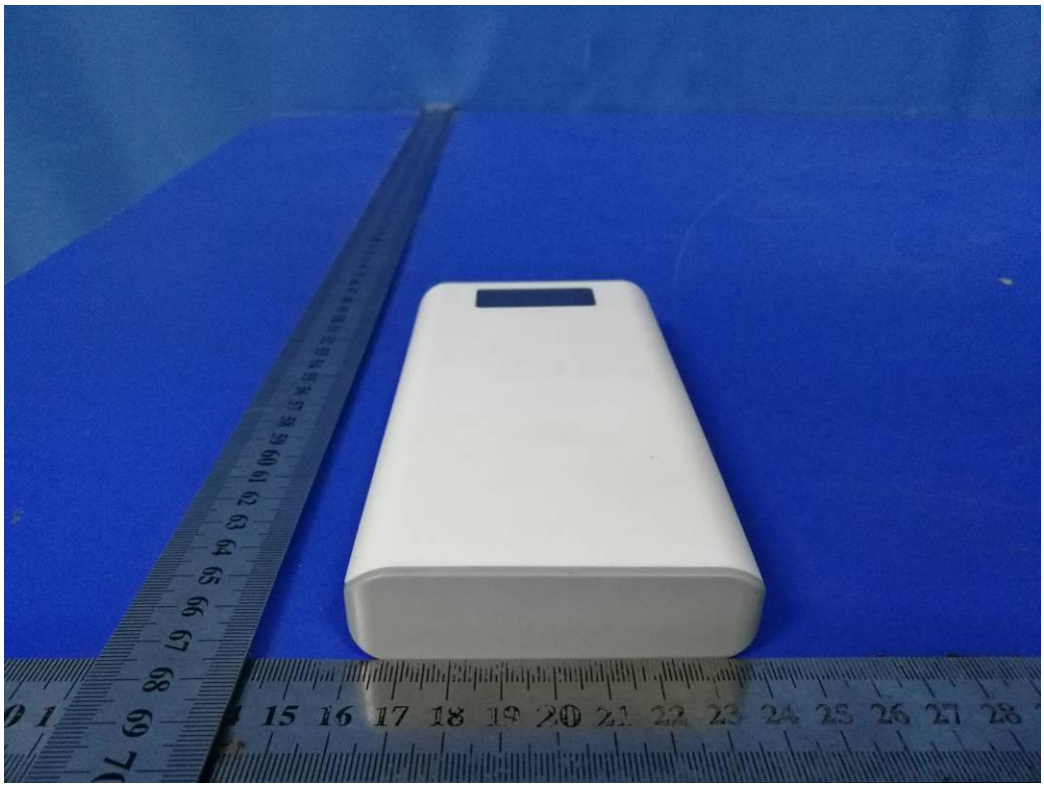


Fig 4

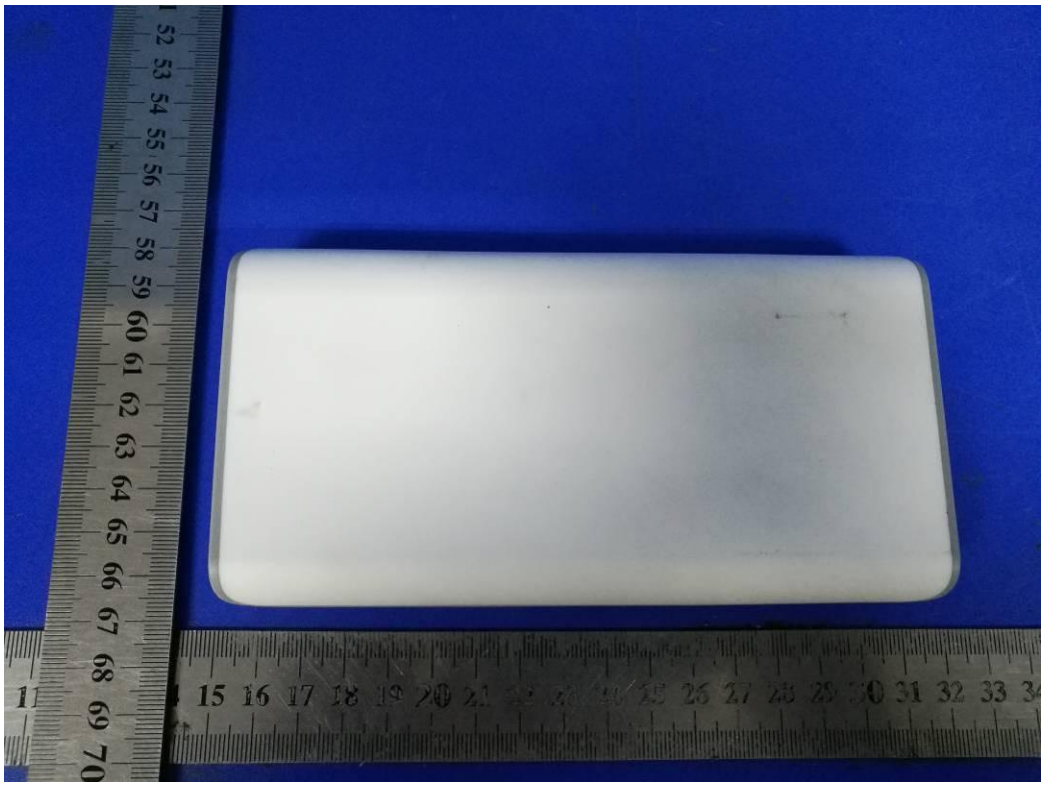


Fig 5

Fig 6

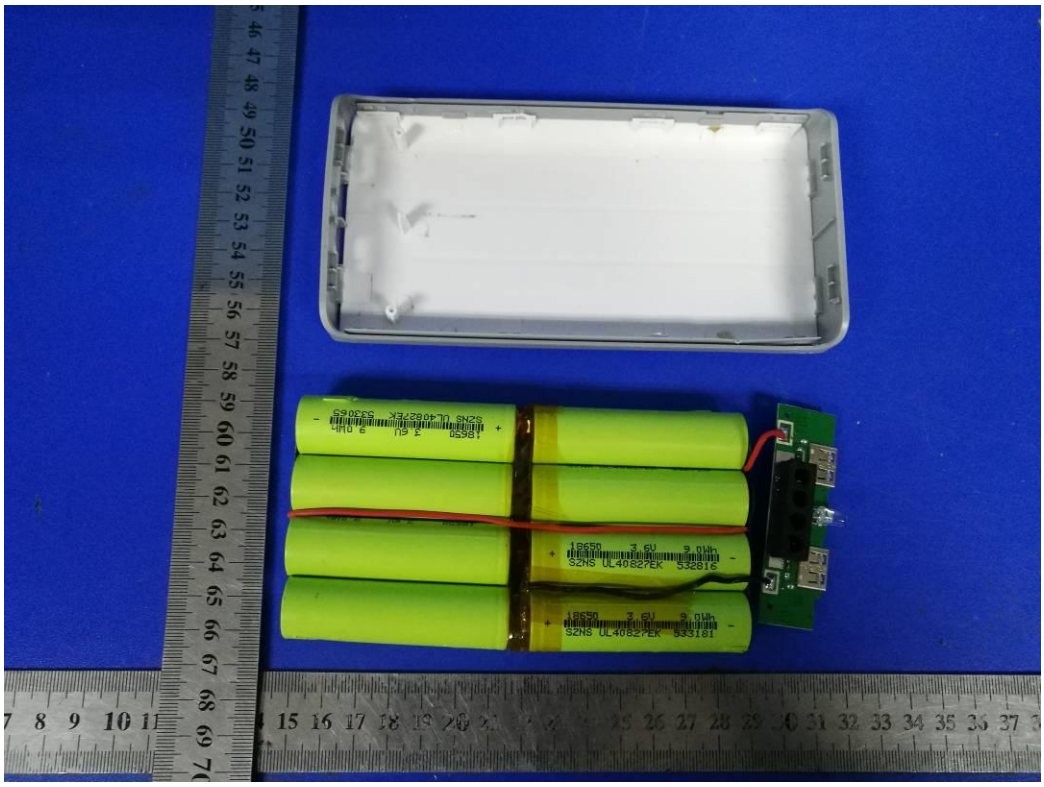

18650 3.6V 9.0Wh
SZNS UL40827EK 532816
18650 3.6V 9.0Wh
SZNS UL40827EK 533181

Fig 7


18650 3.6V 9.0Wh
SZNS UL40827EK 532816
18650 3.6V 9.0Wh
SZNS UL40827EK 533181

Fig 8

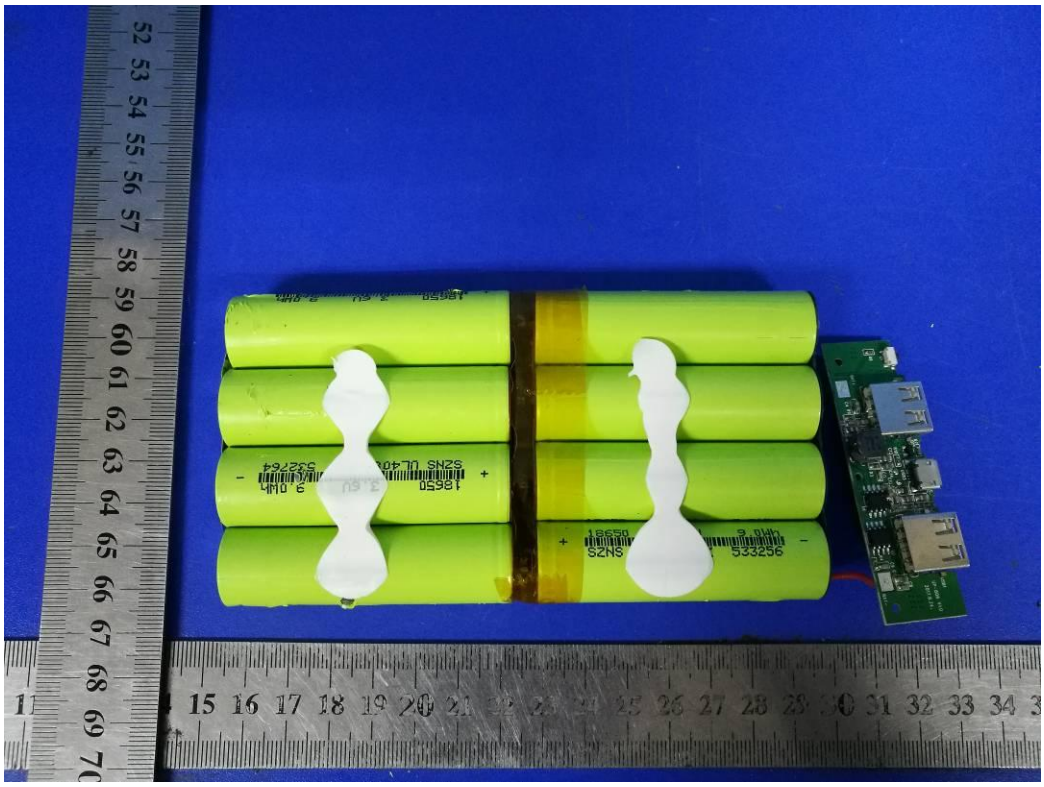


Fig 9

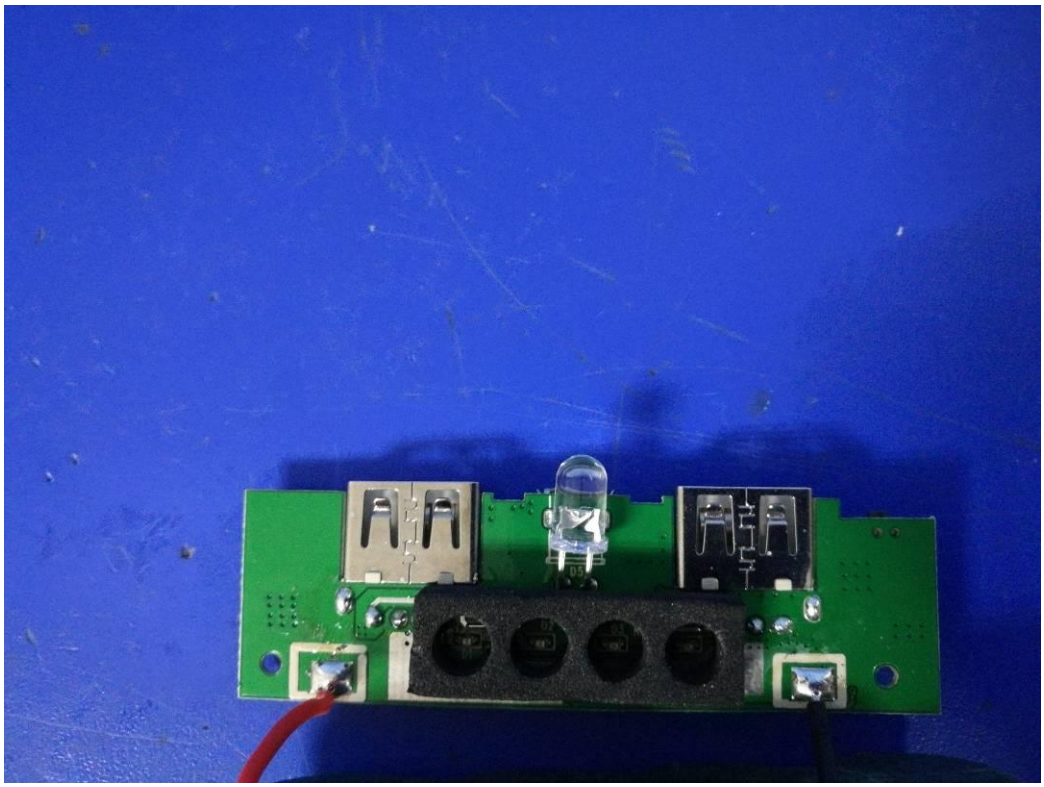


Fig 10

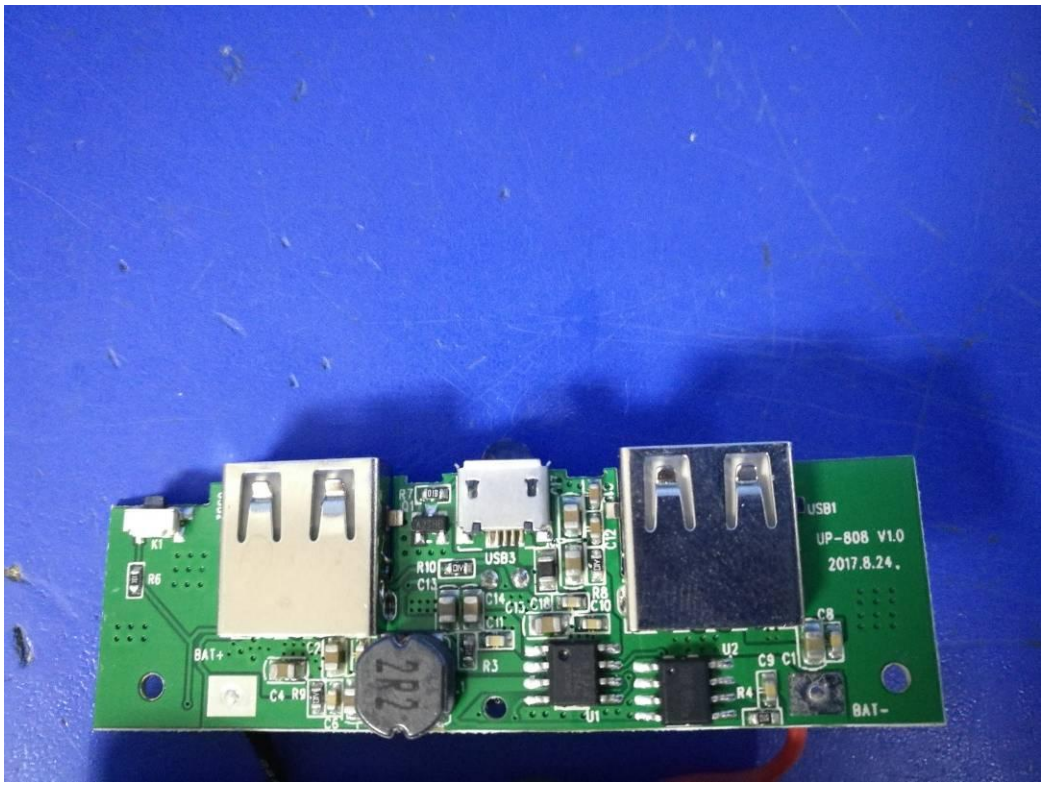


Fig 11

----------THE END OF TEST REPORT----------